

**INFORMATION DISCLOSURE CITATION
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APPLICANT:
Yutaka Saitou et al.
FILING DATE:
January 18, 2005 **GROUP ART UNIT:**
U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date if Appropriate
JY	A	4,471,493	09/1984	Schober			
JY	B	5,014,346	05/1991	Phillips et al.			
JY	C	5,561,437	10/1996	Phillips et al.			
JY	D	2002-0169010	11/2002	Shoji et al.			

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation
JY	E	01-198121	08/1989	JAPAN			Cited in IRS/English Abstract
	F	2-90511	07/1990	JAPAN			Cited on IRS/English Abstract
	G	03-280625	12/1991	JAPAN			Cited on OA/English Abstract
	H	06-216621	08/1994	JAPAN			Cited on IRS/English Abstract
	I	6-31798	08/1994	JAPAN			Cited on OA/English Abstract
	J	0 643 436 A1	03/1995	EUROPE			Cited on IRS/English Text
↓	K	08-078949	03/1996	JAPAN			Cited on IRS/English Text
JY	L	09-064778	03/1997	JAPAN			Cited on pg.2 of Specification /English Abstract

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		Document No.	Date	Country	Class	Subclass	Translation
JY	A	10-065440	03/1998	JAPAN			Cited on IRS/English Abstract
	B	10/084406	03/1998	JAPAN			Cited on pg.2 of Specification /English Abstract
	C	10-190330	07/1998	JAPAN			Cited on pg.2 of Specification /English Abstract
	D	10-190345	07/1998	JAPAN			Cited on IRS & OA/English Translation
	E	10-308618	11/1998	JAPAN			Cited on pg.2 of Specification /English Abstract
	F	11/068901	03/1999	JAPAN			Cited on OA/English Translation
	G	11-136025	05/1999	JAPAN			Cited on IRS/English Abstract
	H	2000-261532	09/2000	JAPAN			Cited on IRS/English Abstract
↓	I	2000-278024	10/2000	JAPAN			Cited on IRS & OA/English Translation
JY	J	1 056 220 A3	11/2000	EUROPE			English Text

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JY	A	2000-341017	12/2000	JAPAN			Cited on OA/English Translation
	B	2001-045123	02/2001	JAPAN			Cited on pg.1 of Specification /English Abstract
	C	2001-077611	03/2001	JAPAN			Cited on IRS/English Abstract
	D	2001-156898	06/2001	JAPAN			Cited on pg.2 of Specification /English Abstract
	E	2001-284934	10/2001	JAPAN			Cited on pg.2 of Specification /English Abstract
	F	2001-358802	12/2001	JAPAN			Cited on OA/English Translation
	G	2002-064314	02/2002	JAPAN			Cited on IRS/English Abstract
↓	H	2002-335180	11/2002	JAPAN			Cited on OA/English Translation
JY	I	1 258 943 A1	11/2002	EUROPE			Cited on OA/English Text

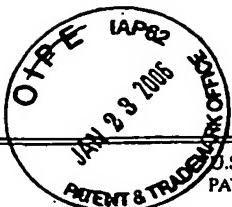
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

J

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
37395SERIAL NO.
10/521,490

**SUPPLEMENTAL INFORMATION DISCLOSURE CITATION
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2681**U.S. PATENT DOCUMENTS**

Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date if Appropriate
JY	A	5,649,306	07/1997	Vannatta et al.	←	→	
	B						
	C						
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		Document No.	Date	Country	Class	Subclass	Translation
JY	L	9-93227	04/1997	JAPAN			Cited on ESR-English Abstract
JY	M	10-224142	08/1998	JAPAN			Cited on ESR-English Abstract
JY	N	WO 01/29927	04/2001	PCT			Cited on ESR-English Abstract
	P						
	Q						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date If Appropriate
JY	A	6,327,485 B1	12/2001	Waldron			
	B						
	C						
	D						
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		Document No.	Date	Country	Class	Subclass	Translation
JY	L	WO 02/03665 A1	01/2002	PCT			Cited on ESR-English Abstract
	M						
	N						
	P						
	Q						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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